



EMC TEST REPORT

According to

EN 55022:2006/A1:2007 (Class B) EN 55024 : 1998/ A1:2001/ A2:2003

N 61000-3-3 : 2008

IEC 61000-4-3 : 2010

IEC 61000-4-4 : 2010

IEC 61000-4-5 : 2005

IEC 61000-4-6 : 2008

IEC 61000-4-8 : 2009

IEC 61000-4-11 : 2004

Applicant : SMART CABLING & TRANSMISSION CORP.

Address 10F, No.493 Chung-Cheng Rd., Hsin Tien City,

Taipei 231, Taiwan, R.O.C.

Equipment : Video Ground Loop Isolator

Model No. : GL00X, GB00X (X=1~9)

Trade Name: SC&T

- The test result refers exclusively to the test presented test model / sample.
- Without written approval of Cerpass Technology Corp., the test report shall not be reproduced except in full.
- This test report is only applicable to European Community.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011



Issued Date : Aug. 10, 2011

: 2 of 35

Page No.

Report No.: TECE1107196

Contents

CE	RTIFIC	ATE OF COMPLIANCE	4
1.	Declar	ation of Conformity and the CE Mark	5
2.	Test C	onfiguration of Equipment under Test	6
	2.1.	Feature of Equipment under Test	6
	2.2.	Test Manner	6
	2.3.	Description of Test System	6
	2.4.	General Information of Test	7
	2.5.	Measurement Uncertainty	
	2.6.	History of this test report	8
3.	Test of	f Conducted Emission	
	3.1.	Test Limit	9
	3.2.	Test Result and Data	9
4.	Test of	f Radiated Emission	10
	4.1.	Test Limit	
	4.2.	Test Procedures	11
	4.3.	Typical Test Setup	11
	4.4.	Measurement Equipment	11
	4.5.	Test Result and Data	
	4.6.	Test Photographs	
5.	Harmo	onics Test	
	5.1.	Limits of Harmonics Current Measurement	
	5.2.	Test Result and Data	
6.	Voltage	e Fluctuations Test	
	6.1.	Test Procedure	
	6.2.	Test Result and Data	
7.	Electro	ostatic Discharge Immunity Test	
	7.1.	Test Procedure	
	7.2.	Test Setup for Tests Performed in Laboratory	
	7.3.	Test Severity Levels	
	7.4.	Measurement Equipment	
	7.5.	Test Result and Data	
	7.6.	Test Photographs	
8.		Frequency Electromagnetic Field Immunity Test	
	8.1.	Test Procedure	
	8.2.	Test Severity Levels	
	8.3.	Measurement Equipment	
	8.4.	Test Result and Data	
	8.5.	Test Photographs	
9.		cal Fast Transient/ Burst Immunity Test	
	9.1.	Test Procedure	
	9.2.	Test Result and Data	
10.	_	Immunity Test	
		Test Procedure	
	10.2.	Test Result and Data	30



CERPASS TECHNOLOGY CORP.



Issued Date : Aug. 10, 2011

: 3 of 35

Page No.

Report No.: TECE1107196

11. Conduction Disturbances induced by Radio-Frequency Fields	31
11.1. Test Procedure	31
11.2. Test Result and Data	31
12. Power Frequency Magnetic Field Immunity Test	32
12.1. Test Setup	32
12.2. Test Severity Levels	32
12.3. Measurement Equipment	32
12.4. Test Result and Data	33
12.5. Test Photographs	34
13. Voltage Dips and Voltage Interruptions Immunity Test Setup	35
13.1. Test Conditions	35
13.2. Test Result and Data	35
Annandix A. Dhatagraphs of ELIT	A1 A3



CERTIFICATE OF COMPLIANCE

According to

EN 55022:2006/A1:2007 (Class B) EN 55024: 1998/ A1:2001/ A2:2003

E N 61000-3-2: 2006/A1:2009/A2:2009

EN 61000-3-3: 2008

IEC 61000-4-2: 2008 IEC 61000-4-3: 2010 IEC 61000-4-4: 2010 IEC 61000-4-5: 2005 IEC 61000-4-6: 2008 IEC 61000-4-8: 2009

IEC 61000-4-11: 2004

Applicant SMART CABLING & TRANSMISSION CORP.

10F, No.493 Chung-Cheng Rd., Hsin Tien City, Address

Taipei 231, Taiwan, R.O.C.

Video Ground Loop Isolator Equipment:

Model No. GL00X, GB00X (X=1~9)

I **HEREBY** CERTIFY THAT:

The measurements shown in this test report were made in accordance with the procedures given in EUROPEAN COUNCIL DIRECTIVE 2004/108/EC.

The equipment was *passed* the test performed according to European Standard EN 55022:2006/A1:2007 (Class B), E N 61000-3-2: 2006/A1:2009/A2:2009, EN 61000-3-3:2008 and EN 55024:1998/ A1:2001/ A2:2003 (IEC 61000-4-2: 2008,

IEC 61000-4-3: 2010, IEC 61000-4-4: 2010, IEC 61000-4-5: 2005, IEC 61000-4-6: 2008, IEC 61000-4-8: 2009, IEC 61000-4-11: 2004). The test was carried out on Aug. 05, 2011 at Cerpass Technology Corp.

Signature

Hill Chen

EMC/RF B.U. / Chief of Engineering dept.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011 Page No. : 4 of 35



: 5 of 35

Report No.: TECE1107196

1. Declaration of Conformity and the CE Mark

There are three possible procedures pertaining to the declaration of conformity:

- 1.1. Conformity Testing and Declaration of Conformity by the Manufacturer or His Authorized Representative Established within the Community or by an Importer.
 - Article 10 (1) of the EMC Directive, § 3 (1) no. 2a of the EMC Act.
- 1.2. Declaration of Conformity Issued by the Manufacturer or His Authorized Representative Established within the Community or by an Importer Following Testing of the Product and Issued of an EC certificate of conformity by a competent body.
 - Article 10 (2) of the EMC Directive, § 3 (1) no. 2b of the EMC Act.
- 1.3. Declaration of Conformity Issued by the Manufacturer or His Authorized Representative Established within the Community or by an Importer Following Testing and Certification of the Product by a Notified Body.
 - Article 10 (5) of the EMC Directive,
 - § 3 (1) no. 2b of the EMC Act (radio transmitting installations).
- 1.4. Specimen For The CE Marking Of Electrical / Electronical Equipment

The components of the CE marking shall have substantially the same vertical dimension, which may not be less than 5 mm.



Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200 Page No.



2. Test Configuration of Equipment under Test

2.1. Feature of Equipment under Test

Please refer to the user manual.

2.2. Test Manner

- a. During testing, the interface cables and equipment positions were varied according to Europe Standard EN 55022 Class B.
- b. The complete test system included Monitor, DVD Player and EUT for EMC test.
- c. The test modes of Radiation test as follow:

Test Mode 1: GL00X, Working Test Mode 2: GB00X, Working

The "Test Mode 1" generated the worst test result, it was reported as final data.

2.3. Description of Test System

Device	Manufacturer	Model No.	Description	
Monitor			Power Cable, Unshielding 1.8m Data Cable, Coaxial Shielding 1.35m	
DVD Player	SONY	DVP-NS718HP	Power Cable, Unshielding 1.8m Data Cable, Coaxial Shielding 1.35m	

Use Cable:

Cable	Quantity	Description	
Coaxial	2	Shielding, 1.35m	

Cerpass Technology Corp.

Tel:886-2-2655-8100 Fax:886-2-2655-8200 Page No.

: 6 of 35



2.4. General Information of Test

	Cerpass Technology Corp.	
Test Site :	2F-11, No. 3, Yuan Qu St., (Nankang Software Park), Taipei, Taiwan 115, R.O.C.	
Test Site Location (OATS2-SD) :	No.68-1, Shihbachongsi, Shihding Township, Taipei City 223, Taiwan, R.O.C.	
FCC Registration Number :	TW1049, TW1061, 488071, 390316	
IC Registration Number :	4934B-1, 4934D-1	
ic Registration Number .	, , , , , , , , , , , , , , , , , , ,	
VCCI Registration Number :	T-543 for Telecommunication Test C-3328 for Conducted emission test R-3013 for Radiated emission test G-97 for radiated disturbance above 1GHz	
Test Voltage:	From System	
Test in Compliance with:	EMI Test (conduction and radiation):	
Frequency Range	Conducted Emission Test: from 150kHz to 30 MHz	
Investigated:	Radiated Emission Test: from 30 MHz to 6,000 MHz	
Test Distance :	The test distance of radiated emission below 1GHz from antenna to EUT is 10 M. The test distance of radiated emission above 1GHz from antenna to EUT is 3 M.	

2.5. Measurement Uncertainty

Measurement Item	Measurement Frequency	Polarization	Uncertainty
Conducted Emission	9 kHz ~ 30 MHz	LINE / NEUTRAL	2.71dB
	30 MHz ~ 1,000 MHz	Vertical	3.52 dB
Radiated Emission	30 MH2 ~ 1,000 MH2	Horizontal	3.39 dB
Radiated Emission	4 000 MH = 40 000 MH =	Vertical	4.39 dB
	1,000 MHz ~ 18,000 MHz	Horizontal	5.25 dB

Issued Date : Aug. 10, 2011 Cerpass Technology Corp.

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Page No.



2.6. History of this test report

\cap	RI	G	IN	Δ	ı
\sim	.	O	II V	~	ᆫ

 \square Additional attachment as following record:

Attachment No.	Issue Date	Description

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Issued Date : Aug. 10, 2011

Page No. : 8 of 35



3. Test of Conducted Emission

3.1. Test Limit

Conducted Emissions were measured from 150 kHz to 30 MHz with a bandwidth of 9 kHz and return leads of the EUT according to the methods defined in European Standard EN 55022. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meters above the ground plane as shown in section 4.2. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

Table 1 Class B Line Conducted Emission Limits:

Frequency range	Limits (dB	μ V)
(MHz)	Quasi Peak	Average
0.15 to 0.50	66 to 56	56 to 46
0.50 to 5	56	46
5. to 30.	60	50

Note 1: The lower limits shall apply at the transition frequencies.

Note 2:The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to .50MHz.

Table 2 - Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class B equipment.

Frequency	Voltage limits		Current limits	
range	dB(μ V)	dB(μ A)	
(MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 to 0.5	84 to 74	74 to 64	40 to 30	30 to 20
0.5 to 30	74	64	30	20

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150 to the telecommunication under test (conversion factor is $20 \log 10 150/1 = 44dB$).

3.2. Test Result and Data

The test item is not applicable because the EUT is unpowered.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200

: 9 of 35

Page No.



4. Test of Radiated Emission

4.1. Test Limit

The EUT shall meet the limits of below Table when measured at the measuring distance R in accordance with the methods described in European Standard EN 55022 Clause 10. If the reading on the measuring receiver shows fluctuations close to the limit, the reading shall be observed for at least 15 s at each measurement frequency; the highest reading shall be recorded, with the exception of any brief isolated high reading, which shall be ignored.

Table – Limits for radiated disturbance of class B ITE at a measuring distance of 10 m

Frequency range	Quasi-peak limits
MHz	dB(μV/m)
30 to 230	30
230 to 1000	37

NOTE 1 The lower limit shall apply at the transition frequency.

NOTE 2 Additional provisions may be required for cases where interference occurs.

The EUT shall meet the limits of below Table when measured in accordance with the method described in European Standard EN 55022 Clause 10 and the conditional testing procedure described below.

Table – Limits for radiated disturbance of class B ITE at a measuring distance of 3 m

Frequency range	Average limit	Peak limits		
GHz	dB(μV/m)	dB(μV/m)		
1 to 3	50	70		
3 to 6 54 74				
NOTE The lower limit applies at the transition frequency.				

· Conditional testing procedure:

The highest internal source of an EUT is defined as the highest frequency generated or used within the EUT or on which the EUT operates or tunes.

If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz.

If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.

If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz.

If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Page No.

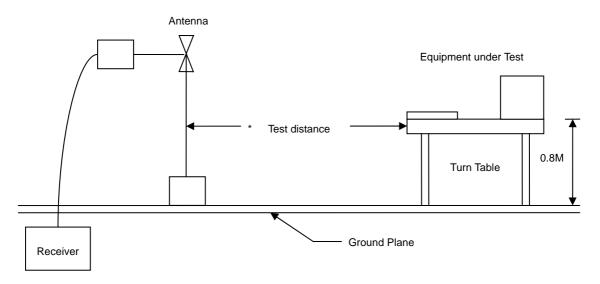
: 10 of 35



4.2. Test Procedures

- a. The EUT was placed on a rotatable table top 0.8 meter above ground.
- b. The EUT was set 3/10 meters from the interference receiving antenna which was mounted on the top of a variable height antenna tower.
- c. The table was rotated 360 degrees to determine the position of the highest radiation.
- d. The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
- e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
- f. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- g. If the emission level of the EUT in peak mode was 3 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method and reported.

4.3. Typical Test Setup



4.4. Measurement Equipment

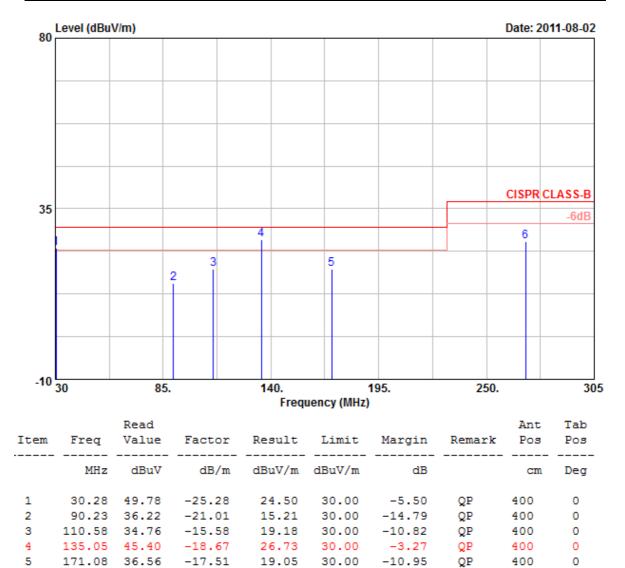
Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
Amplifier	Agilent	8447D	2944A10531	2011/01/21	2012/01/20
Bilog Antenna	Schaffner	CBL6112D	22242	2011/02/09	2012/02/08
EMI Receiver	HP	8546A	3807A00454	2010/09/27	2011/09/26
RF Filter Section	HP	85460A	3704A00386	2010/09/27	2011/09/26
Spectrum Analyzer	R&S	FSP40	100219	2010/11/05	2011/11/04
Horn Antenna	EMCO	3115	31589	2011/05/02	2012/05/01
Preamplifier	Agilent	8449B	3008A01954	2011/03/02	2012/03/01

Cerpass Technology Corp. Issued Date : Aug. 10, 2011



4.5. Test Result and Data

Power :	From System	Pol/Phase :	VERTICAL
Test Mode 1 :	GL00X, Working	Temperature :	24 °C
Memo :		Humidity :	65 %



Remarks: 1. Result = Read Value + Factor

-24.61

2. Factor = Antenna factor + Cable loss - Amplifier factor

-10.76

QP

400

Page No. : 12 of 35

0

26.24 37.00

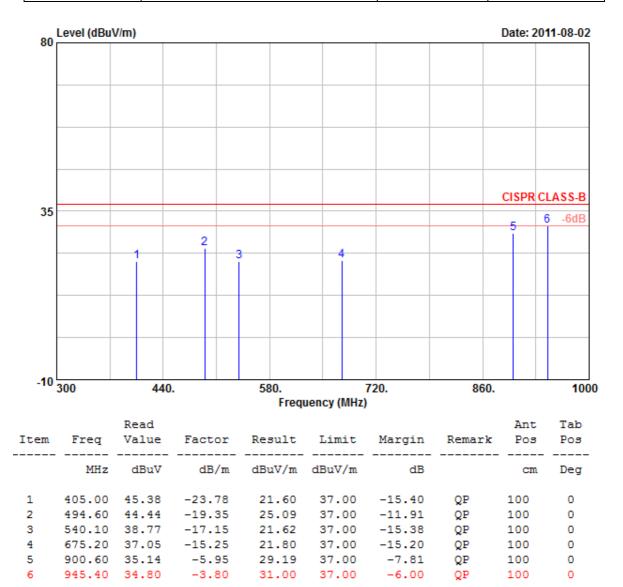
Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200

270.08 50.85



Power :	From System	Pol/Phase :	VERTICAL
Test Mode 1 :	GL00X, Working	Temperature :	24 °C
Memo :		Humidity :	65 %



Remarks: 1. Result = Read Value + Factor

2. Factor = Antenna factor + Cable loss - Amplifier factor

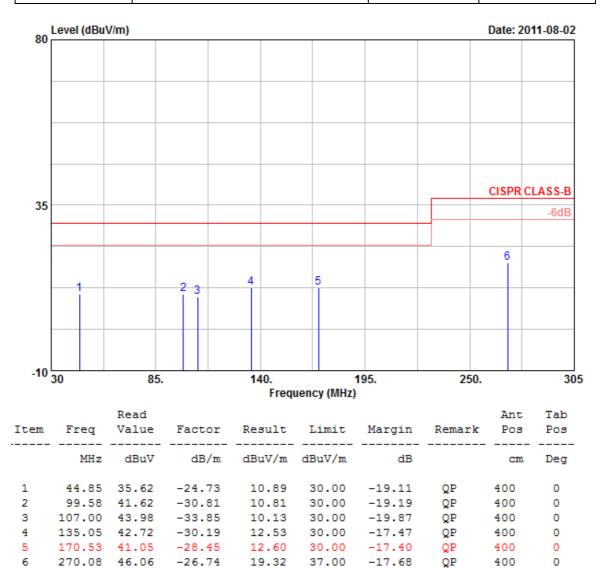
Page No.

: 13 of 35

Cerpass Technology Corp. Issued Date : Aug. 10, 2011



Power	:	From System	Pol/Phase	:	HORIZONTAL
Test Mode 1	:	GL00X, Working	Temperature		24 °C
Memo	:		Humidity	:	65 %



Remarks: 1. Result = Read Value + Factor

2. Factor = Antenna factor + Cable loss - Amplifier factor

Page No. : 14 of 35

Cerpass Technology Corp. Issued Date : Aug. 10, 2011



Power :	From System	Pol/Phase :	HORIZONTAL
Test Mode 1 :	GL00X, Working	Temperature :	24 °C
Memo :		Humidity :	65 %



Remarks: 1. Result = Read Value + Factor

2. Factor = Antenna factor + Cable loss - Amplifier factor

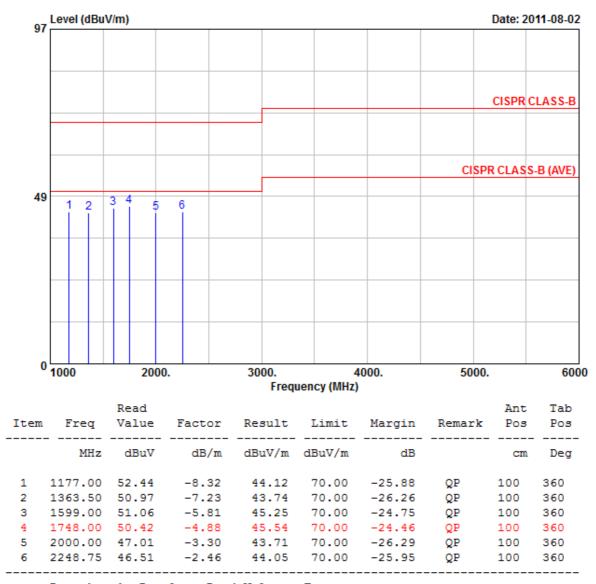
Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Page No. : 15 of 35



Power :	From System	Pol/Phase :	VERTICAL
Test Mode 1 :	GL00X, Working	Temperature :	25 °C
Memo :		Humidity :	49 %



Remarks: 1. Result = Read Value + Factor

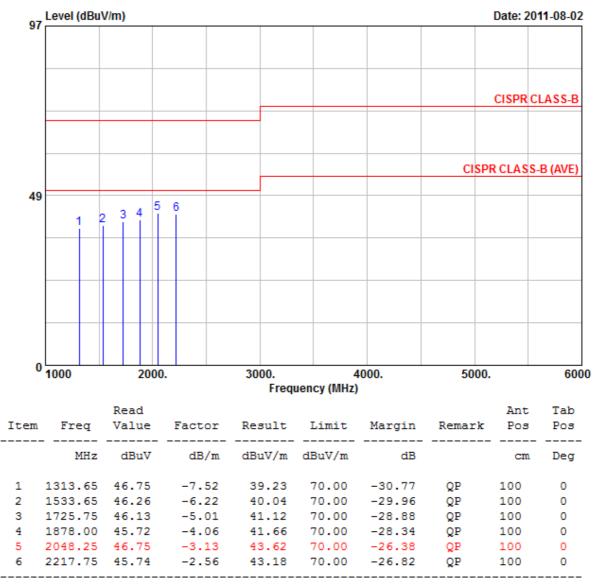
2. Factor = Antenna factor + Cable loss - Amplifier factor

Cerpass Technology Corp.

Tel:886-2-2655-8100 Fax:886-2-2655-8200 Page No. : 16 of 35



Power	:	From System	Pol/Phase :	HORIZONTAL
Test Mode 1	:	GL00X, Working	Temperature :	25 °C
Memo	:		Humidity :	49 %



Remarks: 1. Result = Read Value + Factor

2. Factor = Antenna factor + Cable loss - Amplifier factor

Test engineer:

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Page No. : 17 of 35





4.6. Test Photographs



Front View



Rear View

Cerpass Technology Corp.

Issued Date : Aug. 10, 2011 Tel:886-2-2655-8100 Fax:886-2-2655-8200 Page No. : 18 of 35



5. Harmonics Test

5.1. Limits of Harmonics Current Measurement

Limits for CI	ass A equipment
Harmonics	Max. Permissible
Order	harmonics
n	current
	Α
Odd I	harmonics
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15<=n<=39	0.15×15/n
Even	harmonics
2	1.08
4	0.43
6	0.30
8<=n<=40	0.23×8/n

	Limits for Class D equip	ment
Harmonics	Max. Permissible	Max. Permissible
Order	harmonics current per	harmonics current
n	watt mA/W	Α
	Odd Harmonics onl	у
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13	0.30	0.21
15<=n<=39	3.85/n	0.15 x15/n

Page No.

: 19 of 35

Report No.: TECE1107196

NOTE:

- 1. Class A and Class D are classified according to item section 5 of EN 61000-3-2: 2006/A1:2009/A2:2009.
- According go section 7 of EN 61000-3-2: 2006/A1:2009/A2:2009, the above limits for all
 equipment except for lighting equipment are for all applications having an active input
 power > 75 W and no limits apply for equipment with an active input power up to and
 including 75 W.

5.2. Test Result and Data

The test item is not applicable because the EUT is unpowered.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011



: 20 of 35

6. Voltage Fluctuations Test

6.1. Test Procedure

The equipment shall be tested under the conditions of Clause 5.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of $\pm 8\%$ is achieved during the whole assessment procedure.

6.2. Test Result and Data

The test item is not applicable because the EUT is unpowered.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200 Page No.



7. Electrostatic Discharge Immunity Test

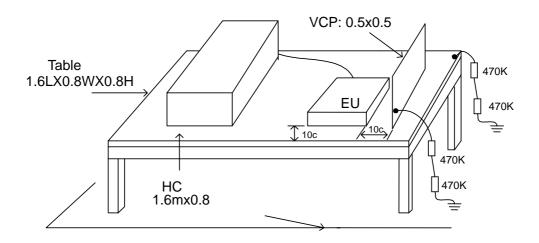
7.1. Test Procedure

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
 - ambient temperature: 15 to 35 ;
 - relative humidity: 30% to 60%;
 - atmospheric pressure: 86 KPa (860 mbar) to 106 KPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On reselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On reselected points at least 25 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted:
 - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
 - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
 - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011



7.2. Test Setup for Tests Performed in Laboratory



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the follow manner:

- a. CONTACT DISCHARGE to the conductive surfaces and to coupling plane;
- b. AIR DISCHARGE at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the Cerpass Technology Corp., we provided 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 2.5 m x 2.5 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1m minimum was provided between the EUT and the wall of the lab. and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall, where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resister located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8m high, standing on the ground reference plane. A HCP, 1.6 m \times 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, 0.5 m \times 0.5 m.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Page No. : 22 of 35



7.3. Test Severity Levels

	Contact Discharge	Air Discharge		
Level	Test Voltage (KV) of Contact discharge	Level	Test Voltage (KV) of Air Discharge	
1	±2	1	±2	
2	±4	2	±4	
3	±6	3	±8	
4	±8	4	±15	
X	Specified	Х	Specified	
	Remark: "X" is ar	n open le	vel.	

7.4. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
ESD Simulator	Schaffner	NSG438	878	2011/06/16	2012/06/15

Issued Date : Aug. 10, 2011 Cerpass Technology Corp.

Tel:886-2-2655-8100 Fax:886-2-2655-8200

: 23 of 35

Page No.





7.5. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A Required performance criteria : B

Basic Standard : IEC 61000-4-2

Product Standard : EN 55024

Test Voltage : $\frac{\pm 2}{\pm 4}$ KV for air discharge, ± 2 / ± 4 KV for contact discharge

Atmospheric Pressure : 1011 hPa
Temperature : 24 °C
Relative Humidity : 52 %

Test Date : Aug. 05, 2011

	Contact Discharge				Contact Discharge Air Discharge					
		times / each				1	<u>0</u> tir	nes / e	ach	
Voltage	2 l	2 KV 4 KV				۲V	4 1	ΚV	8 1	〈 V
Point\Polarity	+	-	+	-	+	-	+	-	+	-
HCP	Α	Α	Α	Α						
VCP	Α	Α	Α	Α						
Case					Α	Α	Α	Α	Α	Α
Coaxial	Α	Α	А	Α						

Note:" A" means the EUT function is normal working during the test.

Test engineer:

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Page No.

: 24 of 35





7.6. Test Photographs



Front View



Issued Date : Aug. 10, 2011

Rear View

Cerpass Technology Corp.

Tel:886-2-2655-8100 Fax:886-2-2655-8200 Page No. : 25 of 35



8. Radio Frequency Electromagnetic Field Immunity Test

8.1. Test Procedure

- a. The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- b. The antenna which is enabling the complete frequency range of 80-1000 MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- c. The test is normally performed with the antenna facing the most sensitive side of the EUT. The polarization of the field generated by the bucolical antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally. The circular polarization of the field from the log-spiral antenna makes a change of position of the antenna unnecessary.
- d. At each of the above conditions, the frequency range is swept 80-1000 MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of 1.5*10-3 decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.

8.2. Test Severity Levels

Frequency Band : 80-1000 MHz		
Level	Test field strength (V/m)	
1	1	
2	3	
3 10		
X Specified		
Remark: "X" is an open class.		

8.3. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
Amplifiers 80-1000MHz/100W	SCHAFFNER	CBA9413B	43510	N/A	N/A
Amplifiers 80-3000MHz/20W	SCHAFFNER	CBA9428	43515	N/A	N/A
Antenna	SCHAFFNER	CBL6141A	4257	N/A	N/A
Power Meter	Boonton	4231A-01	115902	2010/11/30	2011/11/29
Field Probe	HOLADAY	HI-6005	00035824	2011/05/19	2012/05/18
Signal Generator	HP	8648C	3836U02289	2010/11/12	2011/11/11
Power Sensor	Boonton	51011-EMC	33312	2010/11/30	2011/11/29

Cerpass Technology Corp. Issued Date : Aug. 10, 2011



8.4. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A
Required performance criteria : A

Basic Standard : IEC 61000-4-3

Product Standard : EN 55024

Frequency Range : 80~1000 MHz

Atmospheric Pressure : 1011 hPa

Temperature : 24 °C Relative Humidity : 52 %

Test Date : Aug. 05, 2011

Modulation: AM 80%, 1KHz sine wave, Dwell time: 2.9 S Frequency Step Size: 1 % of preceding frequency value

Frequency Step Size . 1 % of preceding frequency value				
Frequency (MHz)	Antenna Polarization	Face	Field strength (V/m)	Result
80~1000	Vertical	Front	3 V/m	А
80~1000	Vertical	Rear	3 V/m	Α
80~1000	Vertical	Left	3 V/m	Α
80~1000	Vertical	Right	3 V/m	А
80~1000	Horizontal	Front	3 V/m	А
80~1000	Horizontal	Rear	3 V/m	А
80~1000	Horizontal	Left	3 V/m	А
80~1000	Horizontal	Right	3 V/m	А

Note: "A" means the EUT function is normal working during the test.

Test engineer:

Issued Date : Aug. 10, 2011

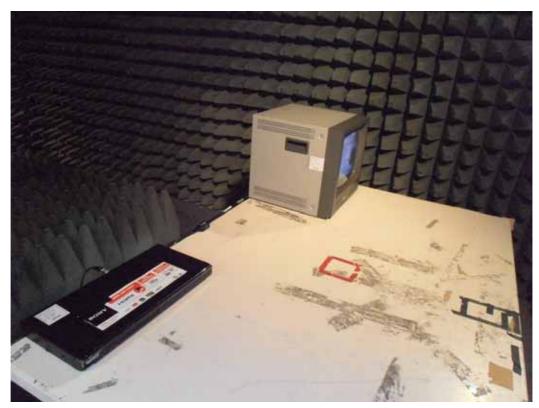
Page No. : 27 of 35



8.5. Test Photographs



Front View



Rear View

Cerpass Technology Corp.

Issued Date : Aug. 10, 2011 Tel:886-2-2655-8100 Fax:886-2-2655-8200 Page No. : 28 of 35



9. Electrical Fast Transient/ Burst Immunity Test

9.1. Test Procedure

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements:
 - ambient temperature: 15 to 35;
 - relative humidity: 45% to 75%;
 - Atmospheric pressure: 86 Kpa (860 mbar) to 106 Kpa (1060 mbar).
- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.
- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.
- d. Test on Power Line:
 - The EFT/B-generator was located on the GRP.. The length from the EFT/B-generator to the EUT is not exceeding 1 m.
 - The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT.
- e. Test on Communication Lines
 - The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP.
 - The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.
- f. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria:
 - · Normal performance within the specification limits.
 - Temporary degradation or loss of function or performance which is self-recoverable.
 - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
 - Degradation or loss of function which is not recoverable due to damage of equipment (components).

9.2. Test Result and Data

The test item is not applicable because the EUT is unpowered.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Page No.

: 29 of 35



10. Surge Immunity Test

10.1. Test Procedure

a. Climatic conditions

The climatic conditions shall comply with the following requirements:

- ambient temperature: 15 to 35
- relative humidity: 10 % to 75 %
- atmospheric pressure: 86 kPa to 106 kPa (860 mbar to 1060 mbar)
- b. Electromagnetic conditions

the electromagnetic environment of the laboratory shall not influence the test results.

- c. The test shall be performed according the test plan that shall specify the test set-up with
 - generator and other equipment utilized;
 - test level (voltage/current);
 - generator source impedance;
 - internal or external generator trigger;
 - number of tests: at least five positive and five negative at the selected points;
 - repetition rate: maximum 1/min.
 - inputs and outputs to be tested;
 - representative operating conditions of the EUT;
 - · sequence of application of the surge to the circuit;
 - phase angle in the case of AC. power supply;
 - actual installation conditions, for example :

AC: neutral earthed,

DC: (+) or (-) earthed to simulated the actual earthing conditions.

- d. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the AC. voltage wave (positive and negative).
- e. The surges have to be applied line to line and line(s) and earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.
- f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan.
- g. All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level (let-through level) of the primary protection.
- h. If the actual operating signal sources are not available, that may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according to a test plan.
- i. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied. For acceptance test previously unstressed equipment shall be used to the protection devices shall be replaced.

10.2. Test Result and Data

Applicable only to parts which according to the manufacturer's specification may connect directly to outdoor cables.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Page No.

: 30 of 35



11. Conduction Disturbances induced by Radio-Frequency Fields

11.1. Test Procedure

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. This test method test can be performed without using a sell shielded enclosure. This is because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies. If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- d. The frequency range is swept from 150 KHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1KHz sign wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed 1.5 x 10⁻³ decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- e. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency (ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- f. An alternative test procedure may be adopted, wherein the frequency range is swept incrementally, with a step size not exceeding 4% of the start ad thereafter 4% of the preceding frequency value. The test level should be at least twice the value of the specified test level.
- g. In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- h. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- i. The use of special exercising programs is recommended.
- Testing shall be performed according to a Test Plan, which shall be included in the test report.
- k. It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

11.2. Test Result and Data

The test item is not applicable because the EUT is unpowered.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

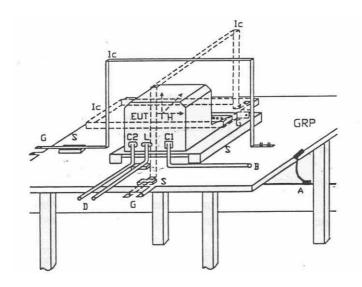
Page No.

: 31 of 35



12. Power Frequency Magnetic Field Immunity Test

12.1. Test Setup



GPR : Ground plane C1 : Power supply circuit

A : Safety earth C2 : Signal circuit

S : Insulating support L : Communication line
EUT : Equipment under test B : To power supply source
Lc : Induction coil D : To signal source, simulator

E : Earth terminal G : To the test generator

12.2. Test Severity Levels

Level	Magnetic field strength		
	A/m		
1	1		
2	3		
3	10		
4	30		
5	100		
X ¹⁾	special		
NOTE 1 "X" is an open level. This level can be givenin the product specification.			

12.3. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
Magnetic Field	KeyTek	F-1000-4-8-G	N/A	2010/10/05	2011/10/04
Generator	Keylek	-125A	IN/A	2010/10/03	2011/10/04

Cerpass Technology Corp. Issued Date : Aug. 10, 2011





12.4. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A

Required performance criteria : A

Basic Standard : IEC 61000-4-8

Product Standard : EN 55024 Atmospheric Pressure : 1011 hPa

Temperature : 24 °C Relative Humidity : 52 %

Test Date : Aug. 05, 2011

Power Frequency Magnetic Field : 50 Hz, 1 A/m			
Coil Orientation	Testing duration	Results	
X-axis	1.0 Min	Α	
Y-axis	1.0 Min	Α	
Z-axis	1.0 Min	Α	

Note: "A" Mean the EUT function is normal working during the test.

Test engineer:

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Page No.

: 33 of 35





12.5. Test Photographs



Front View



Rear View

Cerpass Technology Corp.

Page No. : 34 of 35

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Issued Date : Aug. 10, 2011



13. Voltage Dips and Voltage Interruptions Immunity Test Setup

13.1. Test Conditions

1. Source voltage and frequency: 100/230/240V / 50Hz, Single phase.

2. Test of interval: 10 sec.

3. Level and duration: Sequence of 3 dips/interrupts.

4. Voltage rise (and fall) time : 1 \sim 5 μ s.

5. Test severity:

Voltage dips and Interrupt reduction (%)	Test Duration (period)
>95%	250
30%	25
>95%	0.5

13.2. Test Result and Data

The test item is not applicable because the EUT is unpowered.

Cerpass Technology Corp. Issued Date : Aug. 10, 2011

Tel:886-2-2655-8100 Fax:886-2-2655-8200

: 35 of 35

Page No.



Appendix A. Photographs of EUT

Model No.: GL00X





Cerpass Technology Corp.

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Issued Date : Aug. 10, 2011

Page No. : A1 of A3





Model No.: GB00X



Cerpass Technology Corp.Tel:886-2-2655-8100 Fax:886-2-2655-8200

Issued Date : Aug. 10, 2011

Page No. : A2 of A3









Cerpass Technology Corp.

Tel:886-2-2655-8100 Fax:886-2-2655-8200

Issued Date : Aug. 10, 2011

Page No. : A3 of A3